Search Notes

Application/Control No.	Applicant(s)/Patent Under Reexamination
10560758	MEYER ET AL.
Examiner	Art Unit

1791

SEARCHED				
Class	Subclass		Date	Examiner
156	105, 106, 107		7/29/2009	/JL/

JAEYUN LEE

SEARCH NOTES		
Search Notes	Date	Examiner
Updated East search (US-PGPUB, USPAT, USOCR, FPRS, EPO, JPO,	1/26/2010	/JL/
Derwent, IBM_TDB) and text search		
Consulted Primary Examiner (Jeff Aftergut)	7/22/2009	/JL/

INTERFERENCE SEARCH			
Class	Subclass	Date	Examine
	See Interference Search Printout	1/26/2010	/JL/

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